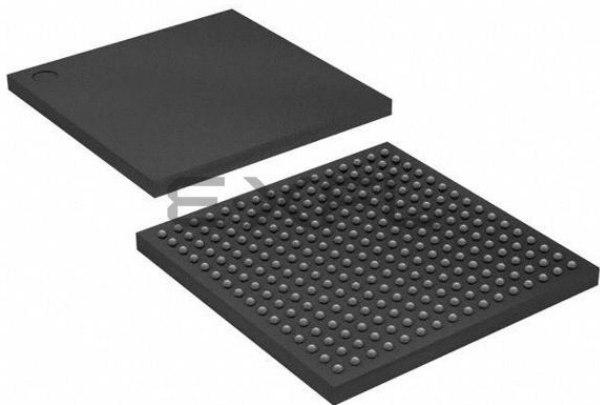




Welcome to [E-XFL.COM](https://www.e-xfl.com)

Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	896
Number of Logic Elements/Cells	8064
Total RAM Bits	368640
Number of I/O	195
Number of Gates	400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	256-LBGA
Supplier Device Package	256-FTBGA (17x17)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s400an-4ft256i

Architectural Overview

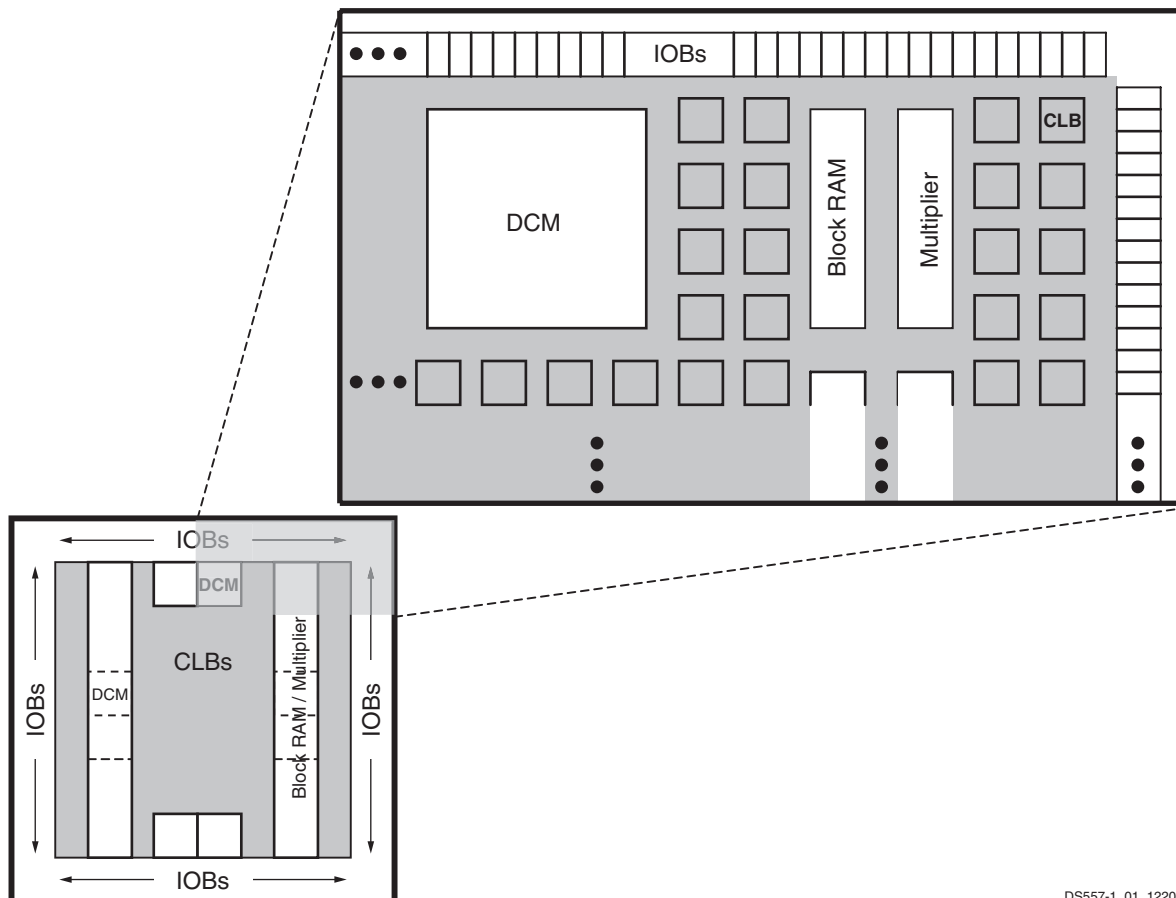
The Spartan-3AN FPGA architecture is compatible with that of the Spartan-3A FPGA. The architecture consists of five fundamental programmable functional elements:

- **Configurable Logic Blocks (CLBs)** contain flexible Look-Up Tables (LUTs) that implement logic plus storage elements used as flip-flops or latches.
- **Input/Output Blocks (IOBs)** control the flow of data between the I/O pins and the internal logic of the device. IOBs support bidirectional data flow plus 3-state operation. They support a variety of signal standards, including several high-performance differential standards. Double Data-Rate (DDR) registers are included.
- **Block RAM** provides data storage in the form of 18-Kbit dual-port blocks.
- **Multiplier Blocks** accept two 18-bit binary numbers as inputs and calculate the product.

- **Digital Clock Manager (DCM) Blocks** provide self-calibrating, fully digital solutions for distributing, delaying, multiplying, dividing, and phase-shifting clock signals.

These elements are organized as shown in Figure 1. A dual ring of staggered IOBs surrounds a regular array of CLBs. Each device has two columns of block RAM except for the XC3S50AN, which has one column. Each RAM column consists of several 18-Kbit RAM blocks. Each block RAM is associated with a dedicated multiplier. The DCMs are positioned in the center with two at the top and two at the bottom of the device. The XC3S50AN has DCMs only at the top, while the XC3S700AN and XC3S1400AN add two DCMs in the middle of the two columns of block RAM and multipliers.

The Spartan-3AN FPGA features a rich network of traces that interconnect all five functional elements, transmitting signals among them. Each functional element has an associated switch matrix that permits multiple connections to the routing.



DS557-1_01_122006

Notes:

1. The XC3S700AN and XC3S1400AN have two additional DCMs on both the left and right sides as indicated by the dashed lines. The XC3S50AN has only two DCMs at the top and only one Block RAM/Multiplier column.

Figure 1: Spartan-3AN Family Architecture

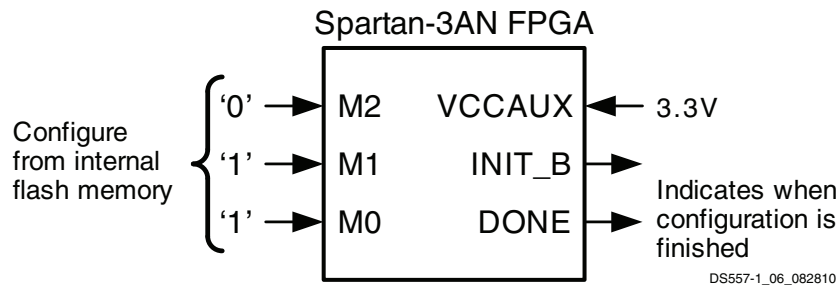


Figure 2: Spartan-3AN FPGA Configuration Interface from Internal SPI Flash Memory

Configuration

Spartan-3AN FPGAs are programmed by loading configuration data into robust, reprogrammable, static CMOS configuration latches (CCLs) that collectively control all functional elements and routing resources. The FPGA's configuration data is stored on-chip in nonvolatile Flash memory, or externally in a PROM or some other nonvolatile medium, either on or off the board. After applying power, the configuration data is written to the FPGA using any of seven different modes:

- Configure from internal SPI Flash memory (Figure 2)
 - Completely self-contained
 - Reduced board space
 - Easy-to-use configuration interface
- Master Serial from a Xilinx Platform Flash PROM
- Serial Peripheral Interface (SPI) from an external industry-standard SPI serial Flash
- Byte Peripheral Interface (BPI) Up from an industry-standard x8 or x8/x16 parallel NOR Flash
- Slave Serial, typically downloaded from a processor
- Slave Parallel, typically downloaded from a processor
- Boundary-Scan (JTAG), typically downloaded from a processor or system tester

The MultiBoot feature stores multiple configuration files in the on-chip Flash, providing extended life with field upgrades. MultiBoot also supports multiple system solutions with a single board to minimize inventory and simplify the addition of new features, even in the field. Flexibility is maintained to do additional MultiBoot configurations via the external configuration method.

The Spartan-3AN device authentication protocol prevents cloning. Design cloning, unauthorized overbuilding, and complete reverse engineering have driven device security requirements to higher and higher levels. Authentication moves the security from bitstream protection to the next generation of design-level security protecting both the design and embedded microcode. The authentication algorithm is entirely user defined, implemented using FPGA logic. Every product, generation, or design can have a different algorithm and functionality to enhance security.

In-System Flash Memory

Each Spartan-3AN FPGA contains abundant integrated SPI serial Flash memory, shown in Table 3, used primarily to store the FPGA's configuration bitstream. However, the Flash memory array is large enough to store at least two MultiBoot FPGA configuration bitstreams or nonvolatile data required by the FPGA application, such as code-shadowed MicroBlaze processor applications.

Table 3: Spartan-3AN Device In-System Flash Memory

Part Number	Total Flash Memory (Bits)	FPGA Bitstream (Bits)	Additional Flash Memory (Bits) ⁽¹⁾
XC3S50AN	1,081,344	437,312	642,048
XC3S200AN	4,325,376	1,196,128	3,127,872
XC3S400AN	4,325,376	1,886,560	2,437,248
XC3S700AN	8,650,752	2,732,640	5,917,824
XC3S1400AN	17,301,504	4,755,296	12,545,280

Notes:

1. Aligned to next available page location.

After configuration, the FPGA design has full access to the in-system Flash memory via an internal SPI interface; the control logic is implemented with FPGA logic. Additionally, the FPGA application itself can store nonvolatile data or provide live, in-system Flash updates.

The Spartan-3AN device in-system Flash memory supports leading-edge serial Flash features.

- Small page size (264 or 528 bytes) simplifies nonvolatile data storage
- Randomly accessible, byte addressable
- Up to 66 MHz serial data transfers
- SRAM page buffers
 - Read Flash data while programming another Flash page
 - EEPROM-like byte write functionality
 - Two buffers in most devices, one in XC3S50AN
- Page, Block, and Sector Erase

Spartan-3AN FPGA Design Documentation

The functionality of the Spartan®-3AN FPGA family is described in the following documents. The topics covered in each guide are listed below:

- **[DS706: Extended Spartan-3A Family Overview](#)**
- **[UG331: Spartan-3 Generation FPGA User Guide](#)**
 - Clocking Resources
 - Digital Clock Managers (DCMs)
 - Block RAM
 - Configurable Logic Blocks (CLBs)
 - Distributed RAM
 - SRL16 Shift Registers
 - Carry and Arithmetic Logic
 - I/O Resources
 - Embedded Multiplier Blocks
 - Programmable Interconnect
 - ISE[®] Design Tools
 - IP Cores
 - Embedded Processing and Control Solutions
 - Pin Types and Package Overview
 - Package Drawings
 - Powering FPGAs
 - Power Management
- **[UG332: Spartan-3 Generation Configuration User Guide](#)**
 - Configuration Overview
 - Configuration Pins and Behavior
 - Bitstream Sizes
 - Detailed Descriptions by Mode
 - Master Serial Mode using Xilinx[®] Platform Flash
 - Master SPI Mode using SPI Serial Flash PROM
 - Internal Master SPI Mode
 - Master BPI Mode using Parallel NOR Flash
 - Slave Parallel (SelectMAP) using a Processor
 - Slave Serial using a Processor
 - JTAG Mode
 - ISE iMPACT Programming Examples
 - MultiBoot Reconfiguration
 - Design Authentication using Device DNA

- **[UG333: Spartan-3AN FPGA In-System Flash User Guide](#)**

- For FPGA applications that write to or read from the In-System Flash memory after configuration
- SPI_ACCESS interface
- In-System Flash memory architecture
- Read, program, and erase commands
- Status registers
- Sector Protection and Sector Lockdown features
- Security Register with Unique Identifier

Create a Xilinx user account and sign up to receive automatic e-mail notification whenever this data sheet or the associated user guides are updated.

- **Sign Up for Alerts on Xilinx.com**
<https://secure.xilinx.com/webreg/register.do?group=myprofile&languageID=1>

Spartan-3AN FPGA Starter Kit

For specific hardware examples, please see the Spartan-3AN FPGA Starter Kit board web page, which has links to various design examples and the user guide.

- **Spartan-3AN FPGA Starter Kit Board Page**
<http://www.xilinx.com/s3anstarter>
- **[UG334: Spartan-3AN FPGA Starter Kit User Guide](#)**

General DC Characteristics for I/O Pins

Table 11: General DC Characteristics of User I/O, Dual-Purpose, and Dedicated Pins

Symbol	Description	Test Conditions		Min	Typ	Max	Units
$I_L^{(2)}$	Leakage current at User I/O, Input-only, Dual-Purpose, and Dedicated pins, FPGA powered	Driver is in a high-impedance state, $V_{IN} = 0V$ or V_{CCO} max, sample-tested		-10	—	+10	μA
I_{HS}	Leakage current on pins during hot socketing, FPGA unpowered	All pins except INIT_B, PROG_B, DONE, and JTAG pins when PUDC_B = 1.		-10	—	+10	μA
		INIT_B, PROG_B, DONE, and JTAG pins or other pins when PUDC_B = 0.		Add $I_{HS} + I_{RPU}$			μA
$I_{RPU}^{(3)}$	Current through pull-up resistor at User I/O, Dual-Purpose, Input-only, and Dedicated pins. Dedicated pins are powered by $V_{CCAUX}^{(4)}$	$V_{IN} = GND$	V_{CCO} or $V_{CCAUX} = 3.0V$ to $3.6V$	-151	-315	-710	μA
			$V_{CCO} = 2.3V$ to $2.7V$	-82	-182	-437	μA
			$V_{CCO} = 1.7V$ to $1.9V$	-36	-88	-226	μA
			$V_{CCO} = 1.4V$ to $1.6V$	-22	-56	-148	μA
			$V_{CCO} = 1.14V$ to $1.26V$	-11	-31	-83	μA
$R_{PU}^{(3)}$	Equivalent pull-up resistor value at User I/O, Dual-Purpose, Input-only, and Dedicated pins (based on I_{RPU} per Note 3)	$V_{IN} = GND$	$V_{CCO} = 3.0V$ to $3.6V$	5.1	11.4	23.9	$k\Omega$
			$V_{CCO} = 2.3V$ to $2.7V$	6.2	14.8	33.1	$k\Omega$
			$V_{CCO} = 1.7V$ to $1.9V$	8.4	21.6	52.6	$k\Omega$
			$V_{CCO} = 1.4V$ to $1.6V$	10.8	28.4	74.0	$k\Omega$
			$V_{CCO} = 1.14V$ to $1.26V$	15.3	41.1	119.4	$k\Omega$
$I_{RPD}^{(3)}$	Current through pull-down resistor at User I/O, Dual-Purpose, Input-only, and Dedicated pins	$V_{IN} = V_{CCO}$	$V_{CCAUX} = 3.0V$ to $3.6V$	167	346	659	μA
$R_{PD}^{(3)}$	Equivalent pull-down resistor value at User I/O, Dual-Purpose, Input-only, and Dedicated pins (based on I_{RPD} per Note 3)	$V_{CCAUX} = 3.0V$ to $3.6V$	$V_{IN} = 3.0V$ to $3.6V$	5.5	10.4	20.8	$k\Omega$
			$V_{IN} = 2.3V$ to $2.7V$	4.1	7.8	15.7	$k\Omega$
			$V_{IN} = 1.7V$ to $1.9V$	3.0	5.7	11.1	$k\Omega$
			$V_{IN} = 1.4V$ to $1.6V$	2.7	5.1	9.6	$k\Omega$
			$V_{IN} = 1.14V$ to $1.26V$	2.4	4.5	8.1	$k\Omega$
I_{REF}	V_{REF} current per pin	All V_{CCO} levels		-10	—	+10	μA
C_{IN}	Input capacitance	—		—	—	10	pF
R_{DT}	Resistance of optional differential termination circuit within a differential I/O pair. Not available on Input-only pairs.	$V_{CCO} = 3.3V \pm 10\%$	LVDS_33, MINI_LVDS_33, RSDS_33	90	100	115	Ω
		$V_{CCO} = 2.5V \pm 10\%$	LVDS_25, MINI_LVDS_25, RSDS_25	90	110	—	Ω

Notes:

- The numbers in this table are based on the conditions set forth in Table 10.
- For single-ended signals that are placed on a differential-capable I/O, V_{IN} of $-0.2V$ to $-0.5V$ is supported but can cause increased leakage between the two pins. See *Parasitic Leakage* in UG331, *Spartan-3 Generation FPGA User Guide*.
- This parameter is based on characterization. The pull-up resistance $R_{PU} = V_{CCO} / I_{RPU}$. The pull-down resistance $R_{PD} = V_{IN} / I_{RPD}$.
- V_{CCAUX} must be 3.3V on Spartan-3AN FPGAs. V_{CCAUX} for Spartan-3A FPGAs can be either 3.3V or 2.5V.

Quiescent Current Requirements

Table 12: Spartan-3AN FPGA Quiescent Supply Current Characteristics

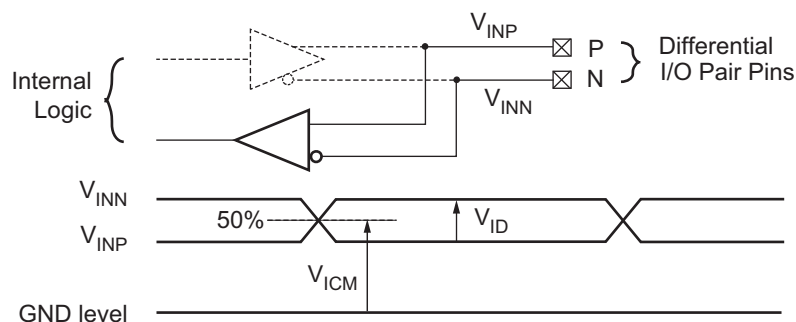
Symbol	Description	Device	Typical ⁽²⁾	Commercial Maximum ⁽²⁾	Industrial Maximum ⁽²⁾	Units
I_{CCINTQ}	Quiescent V_{CCINT} supply current	XC3S50AN	2	20	30	mA
		XC3S200AN	7	50	70	mA
		XC3S400AN	10	85	125	mA
		XC3S700AN	13	120	185	mA
		XC3S1400AN	24	220	310	mA
I_{CCOQ}	Quiescent V_{CCO} supply current	XC3S50AN	0.2	2	3	mA
		XC3S200AN	0.2	2	3	mA
		XC3S400AN	0.3	3	4	mA
		XC3S700AN	0.3	3	4	mA
		XC3S1400AN	0.3	3	4	mA
I_{CCAUXQ}	Quiescent V_{CCAUX} supply current	XC3S50AN	3.1	8.1	10.1	mA
		XC3S200AN	5.1	12.1	15.1	mA
		XC3S400AN	5.1	18.1	24.1	mA
		XC3S700AN	6.1	28.1	34.1	mA
		XC3S1400AN	10.1	50.1	58.1	mA

Notes:

- The numbers in this table are based on the conditions set forth in [Table 10](#).
- Quiescent supply current is measured with all I/O drivers in a high-impedance state and with all pull-up/pull-down resistors at the I/O pads disabled. The internal SPI Flash is deselected (CSB = High); the internal SPI Flash current is consumed on the V_{CCAUX} supply rail. Typical values are characterized using typical devices at room temperature (T_J of 25°C at $V_{CCINT} = 1.2V$, $V_{CCO} = 3.3V$, and $V_{CCAUX} = 3.3V$). The maximum limits are tested for each device at the respective maximum specified junction temperature and at maximum voltage limits with $V_{CCINT} = 1.26V$, $V_{CCO} = 3.6V$, and $V_{CCAUX} = 3.6V$. The FPGA is programmed with a “blank” configuration data file (that is, a design with no functional elements instantiated). For conditions other than those described above (for example, a design including functional elements), measured quiescent current levels will be different than the values in the table.
- There are two recommended ways to estimate the total power consumption (quiescent plus dynamic) for a specific design: a) The [Spartan-3AN FPGA XPower Estimator](#) provides quick, approximate, typical estimates, and does not require a netlist of the design, and b) XPower Analyzer uses a netlist as input to provide maximum estimates as well as more accurate typical estimates. For more information on power for the In-System Flash memory, see the Power Management chapter of [UG333](#).
- The maximum numbers in this table indicate the minimum current each power rail requires in order for the FPGA to power-on successfully.
- For information on the power-saving Suspend mode, see [XAPP480: Using Suspend Mode in Spartan-3 Generation FPGAs](#). Suspend mode typically saves 40% total power consumption compared to quiescent current.

Differential I/O Standards

Differential Input Pairs



$$V_{ICM} = \text{Input common mode voltage} = \frac{V_{INP} + V_{INN}}{2}$$

$$V_{ID} = \text{Differential input voltage} = |V_{INP} - V_{INN}|$$

DS529-3_10_012907

Figure 6: Differential Input Voltages

Table 15: Recommended Operating Conditions for User I/Os Using Differential Signal Standards

IOSTANDARD Attribute	V_{CCO} for Drivers ⁽¹⁾			V_{ID}			V_{ICM} ⁽²⁾		
	Min (V)	Nom (V)	Max (V)	Min (mV)	Nom (mV)	Max (mV)	Min (V)	Nom (V)	Max (V)
LVDS_25 ⁽³⁾	2.25	2.5	2.75	100	350	600	0.3	1.25	2.35
LVDS_33 ⁽³⁾	3.0	3.3	3.6	100	350	600	0.3	1.25	2.35
BLVDS_25 ⁽⁴⁾	2.25	2.5	2.75	100	300	—	0.3	1.3	2.35
MINI_LVDS_25 ⁽³⁾	2.25	2.5	2.75	200	—	600	0.3	1.2	1.95
MINI_LVDS_33 ⁽³⁾	3.0	3.3	3.6	200	—	600	0.3	1.2	1.95
LVPECL_25 ⁽⁵⁾	Inputs Only			100	800	1000	0.3	1.2	1.95
LVPECL_33 ⁽⁵⁾	Inputs Only			100	800	1000	0.3	1.2	2.8 ⁽⁶⁾
RSDS_25 ⁽³⁾	2.25	2.5	2.75	100	200	—	0.3	1.2	1.5
RSDS_33 ⁽³⁾	3.0	3.3	3.6	100	200	—	0.3	1.2	1.5
TMDS_33 ^(3,4,7)	3.14	3.3	3.47	150	—	1200	2.7	—	3.23
PPDS_25 ⁽³⁾	2.25	2.5	2.75	100	—	400	0.2	—	2.3
PPDS_33 ⁽³⁾	3.0	3.3	3.6	100	—	400	0.2	—	2.3
DIFF_HSTL_I_18 ⁽⁸⁾	1.7	1.8	1.9	100	—	—	0.8	—	1.1
DIFF_HSTL_II_18 ^(8,9)	1.7	1.8	1.9	100	—	—	0.8	—	1.1
DIFF_HSTL_III_18 ⁽⁸⁾	1.7	1.8	1.9	100	—	—	0.8	—	1.1
DIFF_HSTL_I ⁽⁸⁾	1.4	1.5	1.6	100	—	—	0.68	—	0.9
DIFF_HSTL_III ⁽⁸⁾	1.4	1.5	1.6	100	—	—	—	0.9	—
DIFF_SSTL18_I ⁽⁸⁾	1.7	1.8	1.9	100	—	—	0.7	—	1.1
DIFF_SSTL18_II ^(8,9)	1.7	1.8	1.9	100	—	—	0.7	—	1.1
DIFF_SSTL2_I ⁽⁸⁾	2.3	2.5	2.7	100	—	—	1.0	—	1.5
DIFF_SSTL2_II ^(8,9)	2.3	2.5	2.7	100	—	—	1.0	—	1.5
DIFF_SSTL3_I ⁽⁸⁾	3.0	3.3	3.6	100	—	—	1.1	—	1.9

Table 15: Recommended Operating Conditions for User I/Os Using Differential Signal Standards (Cont'd)

IOSTANDARD Attribute	V _{CCO} for Drivers ⁽¹⁾			V _{ID}			V _{ICM} ⁽²⁾		
	Min (V)	Nom (V)	Max (V)	Min (mV)	Nom (mV)	Max (mV)	Min (V)	Nom (V)	Max (V)
DIFF_SSTL3_II ⁽⁸⁾	3.0	3.3	3.6	100	—	—	1.1	—	1.9

Notes:

1. The V_{CCO} rails supply only differential output drivers, not input circuits.
2. V_{ICM} must be less than V_{CCAUX}.
3. These true differential output standards are supported only on FPGA banks 0 and 2. Inputs are unrestricted. See the “Using I/O Resources” chapter in [UG331](#).
4. See [External Termination Requirements for Differential I/O, page 22](#).
5. LVPECL is supported on inputs only, not outputs. Requires V_{CCAUX} = 3.3V ± 10%.
6. LVPECL_33 maximum V_{ICM} = V_{CCAUX} - (V_{ID} / 2)
7. Requires V_{CCAUX} = 3.3V ± 10% for inputs. (V_{CCAUX} - 300 mV) ≤ V_{ICM} ≤ (V_{CCAUX} - 37 mV)
8. V_{REF} inputs are used for the DIFF_SSTL and DIFF_HSTL standards. The V_{REF} settings are the same as for the single-ended versions in [Table 13](#). Other differential standards do not use V_{REF}.
9. These higher-drive output standards are supported only on FPGA banks 1 and 3. Inputs are unrestricted. See the “Using I/O Resources” chapter in [UG331](#).

Differential Output Pairs

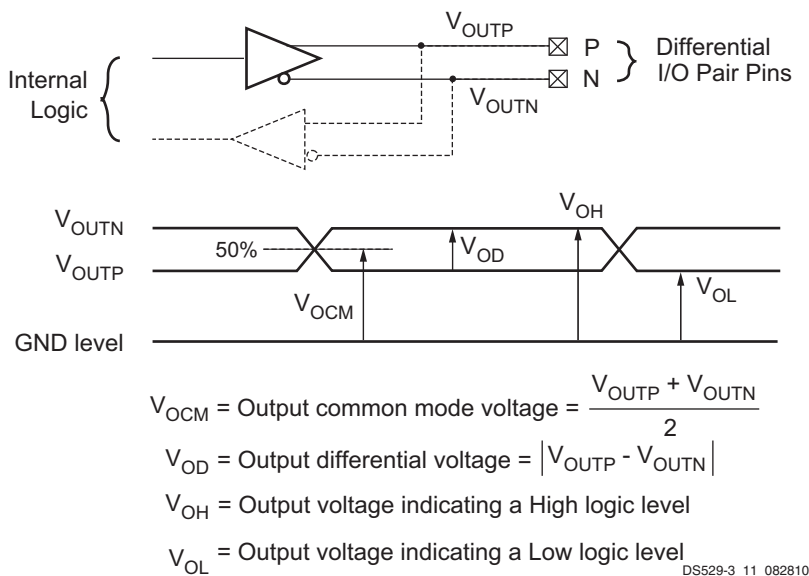


Figure 7: Differential Output Voltages

Output Propagation Times

Table 27: Timing for the IOB Output Path

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max	Max	
Clock-to-Output Times						
T _{IOCKP}	When reading from the Output Flip-Flop (OFF), the time from the active transition at the OCLK input to data appearing at the Output pin	LVC MOS25 ⁽²⁾ , 12 mA output drive, Fast slew rate	All	2.87	3.13	ns
Propagation Times						
T _{IOOP}	The time it takes for data to travel from the IOB's O input to the Output pin	LVC MOS25 ⁽²⁾ , 12 mA output drive, Fast slew rate	All	2.78	2.91	ns
Set/Reset Times						
T _{IOSRP}	Time from asserting the OFF's SR input to setting/resetting data at the Output pin	LVC MOS25 ⁽²⁾ , 12 mA output drive, Fast slew rate	All	3.63	3.89	ns
T _{IOGSRQ}	Time from asserting the Global Set Reset (GSR) input on the STARTUP_SPARTAN3A primitive to setting/resetting data at the Output pin			8.62	9.65	ns

Notes:

1. The numbers in this table are tested using the methodology presented in [Table 30](#) and are based on the operating conditions set forth in [Table 10](#) and [Table 13](#).
2. This time requires adjustment whenever a signal standard other than LVC MOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. When this is true, *add* the appropriate Output adjustment from [Table 29](#).

Table 30: Test Methods for Timing Measurement at I/Os (Cont'd)

Signal Standard (IOSTANDARD)	Inputs			Outputs ⁽²⁾		Inputs and Outputs
	V _{REF} (V)	V _L (V)	V _H (V)	R _T (Ω)	V _T (V)	V _M (V)
Differential						
LVDS_25	–	V _{ICM} – 0.125	V _{ICM} + 0.125	50	1.2	V _{ICM}
LVDS_33	–	V _{ICM} – 0.125	V _{ICM} + 0.125	50	1.2	V _{ICM}
BLVDS_25	–	V _{ICM} – 0.125	V _{ICM} + 0.125	1M	0	V _{ICM}
MINI_LVDS_25	–	V _{ICM} – 0.125	V _{ICM} + 0.125	50	1.2	V _{ICM}
MINI_LVDS_33	–	V _{ICM} – 0.125	V _{ICM} + 0.125	50	1.2	V _{ICM}
LVPECL_25	–	V _{ICM} – 0.3	V _{ICM} + 0.3	N/A	N/A	V _{ICM}
LVPECL_33	–	V _{ICM} – 0.3	V _{ICM} + 0.3	N/A	N/A	V _{ICM}
RSDS_25	–	V _{ICM} – 0.1	V _{ICM} + 0.1	50	1.2	V _{ICM}
RSDS_33	–	V _{ICM} – 0.1	V _{ICM} + 0.1	50	1.2	V _{ICM}
TMDS_33	–	V _{ICM} – 0.1	V _{ICM} + 0.1	50	3.3	V _{ICM}
PPDS_25	–	V _{ICM} – 0.1	V _{ICM} + 0.1	50	0.8	V _{ICM}
PPDS_33	–	V _{ICM} – 0.1	V _{ICM} + 0.1	50	0.8	V _{ICM}
DIFF_HSTL_I	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	0.75	V _{ICM}
DIFF_HSTL_III	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	1.5	V _{ICM}
DIFF_HSTL_I_18	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	0.9	V _{ICM}
DIFF_HSTL_II_18	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	0.9	V _{ICM}
DIFF_HSTL_III_18	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	1.8	V _{ICM}
DIFF_SSTL18_I	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	0.9	V _{ICM}
DIFF_SSTL18_II	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	0.9	V _{ICM}
DIFF_SSTL2_I	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	1.25	V _{ICM}
DIFF_SSTL2_II	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	1.25	V _{ICM}
DIFF_SSTL3_I	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	1.5	V _{ICM}
DIFF_SSTL3_II	–	V _{ICM} – 0.5	V _{ICM} + 0.5	50	1.5	V _{ICM}

Notes:

- Descriptions of the relevant symbols are as follows:
V_{REF} – The reference voltage for setting the input switching threshold
V_{ICM} – The common mode input voltage
V_M – Voltage of measurement point on signal transition
V_L – Low-level test voltage at Input pin
V_H – High-level test voltage at Input pin
R_T – Effective termination resistance, which takes on a value of 1 MΩ when no parallel termination is required
V_T – Termination voltage
- The load capacitance (C_L) at the Output pin is 0 pF for all signal standards.
- According to the PCI specification. For information on PCI IP solutions, see www.xilinx.com/products/design_resources/conn_central/protocols/pci_pcix.htm. The PCIX IOSTANDARD is available and has equivalent characteristics but no PCI-X IP is supported.

The capacitive load (C_L) is connected between the output and GND. *The Output timing for all standards, as published in the speed files and the data sheet, is always based on a C_L value of zero.* High-impedance probes (less than 1 pF) are used for all measurements. Any delay that the test fixture might contribute to test measurements is subtracted from those measurements to produce the final timing numbers as published in the speed files and data sheet.

Table 40: Switching Characteristics for the DLL (Cont'd)

Symbol	Description	Device	Speed Grade				Units
			-5		-4		
			Min	Max	Min	Max	
Delay Lines							
DCM_DELAY_STEP ⁽⁵⁾	Finest delay resolution, average over all taps	All	15	35	15	35	ps

Notes:

1. The numbers in this table are based on the operating conditions set forth in [Table 10](#) and [Table 39](#).
2. Indicates the maximum amount of output jitter that the DCM adds to the jitter on the CLKIN input.
3. For optimal jitter tolerance and faster lock time, use the CLKIN_PERIOD attribute.
4. Some jitter and duty-cycle specifications include 1% of input clock period or 0.01 UI. For example, the data sheet specifies a maximum jitter of “±[1% of CLKIN period + 150]”. Assume the CLKIN frequency is 100 MHz. The equivalent CLKIN period is 10 ns and 1% of 10 ns is 0.1 ns or 100 ps. According to the data sheet, the maximum jitter is ±[100 ps + 150 ps] = ±250 ps.
5. The typical delay step size is 23 ps.

Digital Frequency Synthesizer (DFS)

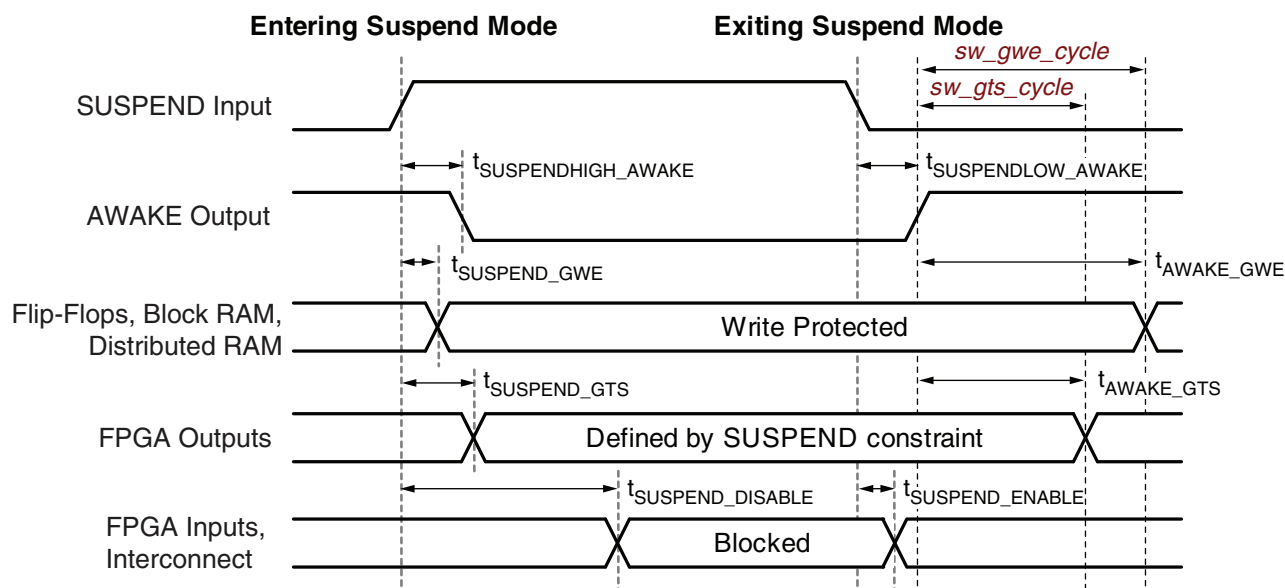
Table 41: Recommended Operating Conditions for the DFS

Symbol		Description	Speed Grade				Units	
			-5		-4			
			Min	Max	Min	Max		
Input Frequency Ranges ⁽²⁾								
F _{CLKIN}	CLKIN_FREQ_FX	Frequency for the CLKIN input	0.200	333 ⁽³⁾	0.200	333 ⁽³⁾	MHz	
Input Clock Jitter Tolerance ⁽⁴⁾								
CLKIN_CYC_JITT_FX_LF		Cycle-to-cycle jitter at the CLKIN input, based on CLKFX output frequency	F _{CLKFX} ≤ 150 MHz	—	±300	—	±300	ps
CLKIN_CYC_JITT_FX_HF			F _{CLKFX} > 150 MHz	—	±150	—	±150	ps
CLKIN_PER_JITT_FX		Period jitter at the CLKIN input	—	±1	—	±1	ns	

Notes:

1. DFS specifications apply when either of the DFS outputs (CLKFX or CLKFX180) are used.
2. If both DFS and DLL outputs are used on the same DCM, follow the more restrictive CLKIN_FREQ_DLL specifications in [Table 39](#).
3. To support double the maximum effective FCLKIN limit, set the CLKIN_DIVIDE_BY_2 attribute to TRUE. This attribute divides the incoming clock frequency by two as it enters the DCM.
4. CLKIN input jitter beyond these limits may cause the DCM to lose lock.

Suspend Mode Timing



DS610-3_08_061207

Figure 12: Suspend Mode Timing

Table 49: Suspend Mode Timing Parameters

Symbol	Description	Min	Typ	Max	Units
Entering Suspend Mode					
$T_{\text{SUSPENDHIGH_AWAKE}}$	Rising edge of SUSPEND pin to falling edge of AWAKE pin without glitch filter (<i>suspend_filter:No</i>)	—	7	—	ns
$T_{\text{SUSPENDFILTER}}$	Adjustment to SUSPEND pin rising edge parameters when glitch filter enabled (<i>suspend_filter:Yes</i>)	+160	+300	+600	ns
$T_{\text{SUSPEND_GTS}}$	Rising edge of SUSPEND pin until FPGA output pins drive their defined SUSPEND constraint behavior	—	10	—	ns
$T_{\text{SUSPEND_GWE}}$	Rising edge of SUSPEND pin to write-protect lock on all writable clocked elements	—	< 5	—	ns
$T_{\text{SUSPEND_DISABLE}}$	Rising edge of the SUSPEND pin to FPGA input pins and interconnect disabled	—	340	—	ns
Exiting Suspend Mode					
$T_{\text{SUSPENDLOW_AWAKE}}$	Falling edge of the SUSPEND pin to rising edge of the AWAKE pin Does not include DCM lock time	—	4 to 108	—	μ s
$T_{\text{SUSPEND_ENABLE}}$	Falling edge of the SUSPEND pin to FPGA input pins and interconnect re-enabled	—	3.7 to 109	—	μ s
$T_{\text{AWAKE_GWE1}}$	Rising edge of the AWAKE pin until write-protect lock released on all writable clocked elements, using <i>sw_clk:InternalClock</i> and <i>sw_gwe_cycle:1</i>	—	67	—	ns
$T_{\text{AWAKE_GWE512}}$	Rising edge of the AWAKE pin until write-protect lock released on all writable clocked elements, using <i>sw_clk:InternalClock</i> and <i>sw_gwe_cycle:512</i>	—	14	—	μ s
$T_{\text{AWAKE_GTS1}}$	Rising edge of the AWAKE pin until outputs return to the behavior described in the FPGA application, using <i>sw_clk:InternalClock</i> and <i>sw_gts_cycle:1</i>	—	57	—	ns
$T_{\text{AWAKE_GTS512}}$	Rising edge of the AWAKE pin until outputs return to the behavior described in the FPGA application, using <i>sw_clk:InternalClock</i> and <i>sw_gts_cycle:512</i>	—	14	—	μ s

Notes:

- These parameters based on characterization.
- For information on using the Spartan-3AN Suspend feature, see [XAPP480: Using Suspend Mode in Spartan-3 Generation FPGAs](#).

Table 52: Master Mode CCLK Output Frequency by ConfigRate Option Setting

Symbol	Description	ConfigRate Setting	Temperature Range	Minimum	Maximum	Units
F_{CCLK1}	Equivalent CCLK clock frequency by ConfigRate setting	1 (power-on value)	Commercial	0.400	0.797	MHz
			Industrial		0.847	MHz
F_{CCLK3}		3	Commercial	1.20	2.42	MHz
			Industrial		2.57	MHz
F_{CCLK6}		6 (default)	Commercial	2.40	4.83	MHz
			Industrial		5.13	MHz
F_{CCLK7}		7	Commercial	2.80	5.61	MHz
			Industrial		5.96	MHz
F_{CCLK8}		8	Commercial	3.20	6.41	MHz
			Industrial		6.81	MHz
F_{CCLK10}		10	Commercial	4.00	8.12	MHz
			Industrial		8.63	MHz
F_{CCLK12}		12	Commercial	4.80	9.70	MHz
			Industrial		10.31	MHz
F_{CCLK13}		13	Commercial	5.20	10.69	MHz
			Industrial		11.37	MHz
F_{CCLK17}		17	Commercial	6.80	13.74	MHz
			Industrial		14.61	MHz
F_{CCLK22}		22	Commercial	8.80	18.44	MHz
			Industrial		19.61	MHz
F_{CCLK25}		25	Commercial	10.00	20.90	MHz
			Industrial		22.23	MHz
F_{CCLK27}		27	Commercial	10.80	22.39	MHz
			Industrial		23.81	MHz
F_{CCLK33}		33	Commercial	13.20	27.48	MHz
			Industrial		29.23	MHz
F_{CCLK44}		44	Commercial	17.60	37.60	MHz
			Industrial		40.00	MHz
F_{CCLK50}		50	Commercial	20.00	44.80	MHz
			Industrial		47.66	MHz
$F_{CCLK100}$		100	Commercial	40.00	88.68	MHz
			Industrial		94.34	MHz

Table 53: Master Mode CCLK Output Minimum Low and High Time

Symbol	Description		ConfigRate Setting																Units
			1	3	6	7	8	10	12	13	17	22	25	27	33	44	50	100	
T_{MCCL} , T_{MCCH}	Master Mode CCLK Minimum Low and High Time	Commercial	595	196	98.3	84.5	74.1	58.4	48.9	44.1	34.2	25.6	22.3	20.9	17.1	12.3	10.4	5.3	ns
		Industrial	560	185	92.6	79.8	69.8	55.0	46.0	41.8	32.3	24.2	21.4	20.0	16.2	11.9	10.0	5.0	ns

Table 59: Timing for Byte-wide Peripheral Interface (BPI) Configuration Mode

Symbol	Description	Minimum	Maximum	Units
T_{CCLK1}	Initial CCLK clock period	See Table 51		
T_{CCLKn}	CCLK clock period after FPGA loads ConfigRate setting	See Table 51		
T_{MINIT}	Setup time on M[2:0] mode pins before the rising edge of INIT_B	50	—	ns
T_{INITM}	Hold time on M[2:0] mode pins after the rising edge of INIT_B	0	—	ns
$T_{INITADDR}$	Minimum period of initial A[25:0] address cycle; LDC[2:0] and HDC are asserted and valid	5	5	T_{CCLK1} cycles
T_{CCO}	Address A[25:0] outputs valid after CCLK falling edge	See Table 55		
T_{DCC}	Setup time on D[7:0] data inputs before CCLK rising edge	See T_{SMDCC} in Table 56		
T_{CCD}	Hold time on D[7:0] data inputs after CCLK rising edge	0	—	ns

Table 60: Configuration Timing Requirements for Attached Parallel NOR Flash

Symbol	Description	Requirement	Units
T_{CE} (t_{ELQV})	Parallel NOR Flash PROM chip-select time	$T_{CE} \leq T_{INITADDR}$	ns
T_{OE} (t_{GLQV})	Parallel NOR Flash PROM output-enable time	$T_{OE} \leq T_{INITADDR}$	ns
T_{ACC} (t_{AVQV})	Parallel NOR Flash PROM read access time	$T_{ACC} \leq 0.5 T_{CCLKn(min)} - T_{CCO} - T_{DCC} - PCB$	ns
T_{BYTE} (t_{FLQV}, t_{FHQV})	For x8/x16 PROMs only: BYTE# to output valid time ⁽³⁾	$T_{BYTE} \leq T_{INITADDR}$	ns

Notes:

- These requirements are for successful FPGA configuration in BPI mode, where the FPGA generates the CCLK signal. The post-configuration timing can be different to support the specific needs of the application loaded into the FPGA.
- Subtract additional printed circuit board routing delay as required by the application.
- The initial BYTE# timing can be extended using an external, appropriately sized pull-down resistor on the FPGA's LDC2 pin. The resistor value also depends on whether the FPGA's PUDC_B pin is High or Low.

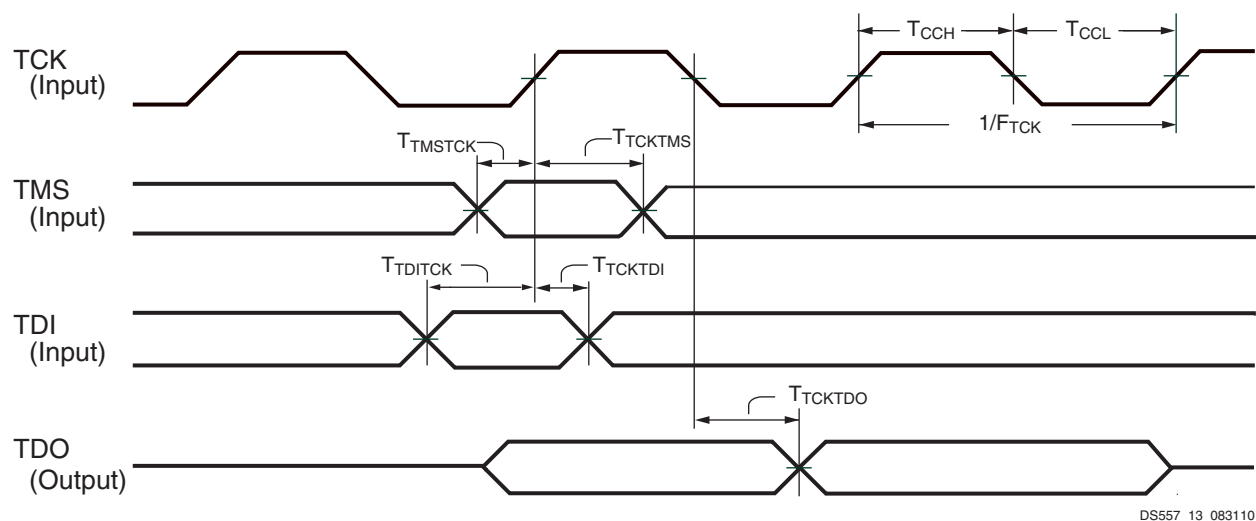
IEEE 1149.1/1532 JTAG Test Access Port Timing


Figure 18: JTAG Waveforms

FTG256: 256-Ball Fine-Pitch, Thin Ball Grid Array

The 256-ball fine-pitch, thin ball grid array package, FTG256, supports the XC3S50AN, XC3S200AN, and XC3S400AN devices. Table 70 lists all the package pins for these devices. They are sorted by bank number and then by the pin name of the largest device. Pins that form a differential I/O pair appear together in the table. The differential I/O pairs that have different assignments between the XC3S50AN and the XC3S200AN or XC3S400AN are highlighted in light blue in Table 70. See [Footprint Migration Differences, page 87](#) for additional information. The table also shows the pin number for each pin and the pin type (as defined in Table 62).

The footprints for the XC3S200AN and XC3S400AN in the FTG256 are identical. Figure 21 shows the common footprint for the XC3S200AN and XC3S400AN. The XC3S50AN footprint is compatible with the XC3S200AN and XC3S400AN, however, there are 51 unconnected balls (indicated as N.C. in Table 70).

Table 73 summarizes the XC3S50AN FPGA footprint migration differences for the FTG256 package.

The XC3S50AN does not support the address output pins for the byte-wide peripheral interface (BPI) configuration mode.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at: www.xilinx.com/support/documentation/data_sheets/s3a_pin.zip.

Pinout Table

Table 70: Spartan-3AN FTG256 Pinout (XC3S50AN, XC3S200AN, XC3S400AN)

Bank	XC3S50AN Pin Name	XC3S200AN/XC3S400AN Pin Name	FTG256 Ball	Type
0	IO_L01N_0	IO_L01N_0	C13	I/O
0	IO_L01P_0	IO_L01P_0	D13	I/O
0	IO_L02N_0	IO_L02N_0	B14	I/O
0	IO_L02P_0/VREF_0	IO_L02P_0/VREF_0	B15	VREF
0	IO_L03N_0	IO_L03N_0	D11	I/O
0	IO_L03P_0	IO_L03P_0	C12	I/O
0	IO_L04N_0	IO_L04N_0	A13	I/O
0	IO_L04P_0	IO_L04P_0	A14	I/O
0	N.C.	IO_L05N_0	A12	I/O
0	IP_0	IO_L05P_0	B12	I/O
0	N.C.	IO_L06N_0/VREF_0	E10	VREF
0	N.C.	IO_L06P_0	D10	I/O
0	IO_L07N_0	IO_L07N_0	A11	I/O
0	IO_L07P_0	IO_L07P_0	C11	I/O
0	IO_L08N_0	IO_L08N_0	A10	I/O
0	IO_L08P_0	IO_L08P_0	B10	I/O
0	IO_L09N_0/GCLK5	IO_L09N_0/GCLK5	D9	GCLK
0	IO_L09P_0/GCLK4	IO_L09P_0/GCLK4	C10	GCLK
0	IO_L10N_0/GCLK7	IO_L10N_0/GCLK7	A9	GCLK
0	IO_L10P_0/GCLK6	IO_L10P_0/GCLK6	C9	GCLK
0	IO_L11N_0/GCLK9	IO_L11N_0/GCLK9	D8	GCLK
0	IO_L11P_0/GCLK8	IO_L11P_0/GCLK8	C8	GCLK
0	IO_L12N_0/GCLK11	IO_L12N_0/GCLK11	B8	GCLK
0	IO_L12P_0/GCLK10	IO_L12P_0/GCLK10	A8	GCLK
0	N.C.	IO_L13N_0	C7	I/O
0	N.C.	IO_L13P_0	A7	I/O

Table 70: Spartan-3AN FTG256 Pinout (XC3S50AN, XC3S200AN, XC3S400AN) (Cont'd)

Bank	XC3S50AN Pin Name	XC3S200AN/XC3S400AN Pin Name	FTG256 Ball	Type
GND	GND	GND	J8	GND
GND	GND	GND	K2	GND
GND	GND	GND	K7	GND
GND	GND	GND	K9	GND
GND	GND	GND	L11	GND
GND	GND	GND	L15	GND
GND	GND	GND	M5	GND
GND	GND	GND	M12	GND
GND	GND	GND	P3	GND
GND	GND	GND	P14	GND
GND	GND	GND	R6	GND
GND	GND	GND	R10	GND
GND	GND	GND	T1	GND
GND	GND	GND	T16	GND
VCCAUX	SUSPEND	SUSPEND	R16	PWR MGMT
VCCAUX	DONE	DONE	T15	CONFIG
VCCAUX	PROG_B	PROG_B	A2	CONFIG
VCCAUX	TCK	TCK	A15	JTAG
VCCAUX	TDI	TDI	B1	JTAG
VCCAUX	TDO	TDO	B16	JTAG
VCCAUX	TMS	TMS	B2	JTAG
VCCAUX	VCCAUX	VCCAUX	E11	VCCAUX
VCCAUX	VCCAUX	VCCAUX	F5	VCCAUX
VCCAUX	VCCAUX	VCCAUX	L12	VCCAUX
VCCAUX	VCCAUX	VCCAUX	M6	VCCAUX
VCCINT	VCCINT	VCCINT	G7	VCCINT
VCCINT	VCCINT	VCCINT	G9	VCCINT
VCCINT	VCCINT	VCCINT	H8	VCCINT
VCCINT	VCCINT	VCCINT	J9	VCCINT
VCCINT	VCCINT	VCCINT	K8	VCCINT
VCCINT	VCCINT	VCCINT	K10	VCCINT

Table 76: Spartan-3AN FGG400 Pinout (Cont'd)

Bank	Pin Name	FGG400 Ball	Type
0	IO_L32N_0/PUDC_B	B2	DUAL
0	IO_L32P_0/VREF_0	A2	VREF
0	IP_0	E14	INPUT
0	IP_0	F11	INPUT
0	IP_0	F14	INPUT
0	IP_0	G8	INPUT
0	IP_0	G9	INPUT
0	IP_0	G10	INPUT
0	IP_0	G12	INPUT
0	IP_0	G13	INPUT
0	IP_0	H9	INPUT
0	IP_0	H10	INPUT
0	IP_0	H11	INPUT
0	IP_0	H12	INPUT
0	IP_0/VREF_0	G11	VREF
0	VCCO_0	B4	VCCO
0	VCCO_0	B10	VCCO
0	VCCO_0	B16	VCCO
0	VCCO_0	D7	VCCO
0	VCCO_0	D13	VCCO
0	VCCO_0	F10	VCCO
1	IO_L01N_1/LDC2	V20	DUAL
1	IO_L01P_1/HDC	W20	DUAL
1	IO_L02N_1/LDC0	U18	DUAL
1	IO_L02P_1/LDC1	V19	DUAL
1	IO_L03N_1/A1	R16	DUAL
1	IO_L03P_1/A0	T17	DUAL
1	IO_L05N_1	T20	I/O
1	IO_L05P_1	T18	I/O
1	IO_L06N_1	U20	I/O
1	IO_L06P_1	U19	I/O
1	IO_L07N_1	P17	I/O
1	IO_L07P_1	P16	I/O
1	IO_L08N_1	R17	I/O
1	IO_L08P_1	R18	I/O
1	IO_L09N_1	R20	I/O
1	IO_L09P_1	R19	I/O
1	IO_L10N_1/VREF_1	P20	VREF
1	IO_L10P_1	P18	I/O
1	IO_L12N_1/A3	N17	DUAL

Table 76: Spartan-3AN FGG400 Pinout (Cont'd)

Bank	Pin Name	FGG400 Ball	Type
1	IO_L12P_1/A2	N15	DUAL
1	IO_L13N_1/A5	N19	DUAL
1	IO_L13P_1/A4	N18	DUAL
1	IO_L14N_1/A7	M18	DUAL
1	IO_L14P_1/A6	M17	DUAL
1	IO_L16N_1/A9	L16	DUAL
1	IO_L16P_1/A8	L15	DUAL
1	IO_L17N_1/RHCLK1	M20	RHCLK
1	IO_L17P_1/RHCLK0	M19	RHCLK
1	IO_L18N_1/TRDY1/RHCLK3	L18	RHCLK
1	IO_L18P_1/RHCLK2	L19	RHCLK
1	IO_L20N_1/RHCLK5	L17	RHCLK
1	IO_L20P_1/RHCLK4	K18	RHCLK
1	IO_L21N_1/RHCLK7	J20	RHCLK
1	IO_L21P_1/IRDY1/RHCLK6	K20	RHCLK
1	IO_L22N_1/A11	J18	DUAL
1	IO_L22P_1/A10	J19	DUAL
1	IO_L24N_1	K16	I/O
1	IO_L24P_1	J17	I/O
1	IO_L25N_1/A13	H18	DUAL
1	IO_L25P_1/A12	H19	DUAL
1	IO_L26N_1/A15	G20	DUAL
1	IO_L26P_1/A14	H20	DUAL
1	IO_L28N_1	H17	I/O
1	IO_L28P_1	G18	I/O
1	IO_L29N_1/A17	F19	DUAL
1	IO_L29P_1/A16	F20	DUAL
1	IO_L30N_1/A19	F18	DUAL
1	IO_L30P_1/A18	G17	DUAL
1	IO_L32N_1	E19	I/O
1	IO_L32P_1	E20	I/O
1	IO_L33N_1	F17	I/O
1	IO_L33P_1	E18	I/O
1	IO_L34N_1	D18	I/O
1	IO_L34P_1	D20	I/O
1	IO_L36N_1/A21	F16	DUAL
1	IO_L36P_1/A20	G16	DUAL
1	IO_L37N_1/A23	C19	DUAL
1	IO_L37P_1/A22	C20	DUAL
1	IO_L38N_1/A25	B19	DUAL

Table 76: Spartan-3AN FGG400 Pinout (Cont'd)

Bank	Pin Name	FGG400 Ball	Type
3	IO_L34P_3	U1	I/O
3	IO_L36N_3	T4	I/O
3	IO_L36P_3	R5	I/O
3	IO_L37N_3	V2	I/O
3	IO_L37P_3	V1	I/O
3	IO_L38N_3	W2	I/O
3	IO_L38P_3	W1	I/O
3	IP_3	H7	INPUT
3	IP_L04N_3/VREF_3	G6	VREF
3	IP_L04P_3	G7	INPUT
3	IP_L11N_3/VREF_3	J7	VREF
3	IP_L11P_3	J8	INPUT
3	IP_L15N_3	K7	INPUT
3	IP_L15P_3	K8	INPUT
3	IP_L19N_3	K5	INPUT
3	IP_L19P_3	K6	INPUT
3	IP_L23N_3	L6	INPUT
3	IP_L23P_3	L7	INPUT
3	IP_L27N_3	M7	INPUT
3	IP_L27P_3	M8	INPUT
3	IP_L31N_3	N7	INPUT
3	IP_L31P_3	M6	INPUT
3	IP_L35N_3	N6	INPUT
3	IP_L35P_3	P5	INPUT
3	IP_L39N_3/VREF_3	P7	VREF
3	IP_L39P_3	P6	INPUT
3	VCCO_3	E2	VCCO
3	VCCO_3	H5	VCCO
3	VCCO_3	L2	VCCO
3	VCCO_3	N5	VCCO
3	VCCO_3	U2	VCCO
GND	GND	A1	GND
GND	GND	A11	GND
GND	GND	A20	GND
GND	GND	B6	GND
GND	GND	B14	GND
GND	GND	C3	GND
GND	GND	C18	GND
GND	GND	D9	GND
GND	GND	E5	GND

Table 76: Spartan-3AN FGG400 Pinout (Cont'd)

Bank	Pin Name	FGG400 Ball	Type
GND	GND	E12	GND
GND	GND	F15	GND
GND	GND	G2	GND
GND	GND	G19	GND
GND	GND	H8	GND
GND	GND	H13	GND
GND	GND	J9	GND
GND	GND	J11	GND
GND	GND	K1	GND
GND	GND	K10	GND
GND	GND	K12	GND
GND	GND	K17	GND
GND	GND	L4	GND
GND	GND	L9	GND
GND	GND	L11	GND
GND	GND	L20	GND
GND	GND	M10	GND
GND	GND	M12	GND
GND	GND	N8	GND
GND	GND	N11	GND
GND	GND	N13	GND
GND	GND	P2	GND
GND	GND	P19	GND
GND	GND	R6	GND
GND	GND	R9	GND
GND	GND	T16	GND
GND	GND	U12	GND
GND	GND	V3	GND
GND	GND	V18	GND
GND	GND	W7	GND
GND	GND	W15	GND
GND	GND	Y1	GND
GND	GND	Y10	GND
GND	GND	Y20	GND
VCCAUX	SUSPEND	R15	PWR MGMT
VCCAUX	DONE	W19	CONFIG
VCCAUX	PROG_B	D5	CONFIG
VCCAUX	TCK	A19	JTAG
VCCAUX	TDI	F5	JTAG
VCCAUX	TDO	E17	JTAG

Table 78: Spartan-3AN FGG484 Pinout (Cont'd)

Bank	Pin Name	FGG484 Ball	Type
1	IO_L25N_1/RHCLK7	K19	RHCLK
1	IO_L25P_1/IRDY1/RHCLK6	K20	RHCLK
1	IO_L26N_1/A11	J22	DUAL
1	IO_L26P_1/A10	K22	DUAL
1	IO_L28N_1	L19	I/O
1	IO_L28P_1	L18	I/O
1	IO_L29N_1/A13	J20	DUAL
1	IO_L29P_1/A12	J21	DUAL
1	IO_L30N_1/A15	G22	DUAL
1	IO_L30P_1/A14	H22	DUAL
1	IO_L32N_1	K18	I/O
1	IO_L32P_1	K17	I/O
1	IO_L33N_1/A17	H20	DUAL
1	IO_L33P_1/A16	H21	DUAL
1	IO_L34N_1/A19	F21	DUAL
1	IO_L34P_1/A18	F22	DUAL
1	IO_L36N_1	G20	I/O
1	IO_L36P_1	G19	I/O
1	IO_L37N_1	H19	I/O
1	IO_L37P_1	J18	I/O
1	IO_L38N_1	F20	I/O
1	IO_L38P_1	E20	I/O
1	IO_L40N_1	F18	I/O
1	IO_L40P_1	F19	I/O
1	IO_L41N_1	D22	I/O
1	IO_L41P_1	E22	I/O
1	IO_L42N_1	D20	I/O
1	IO_L42P_1	D21	I/O
1	IO_L44N_1/A21	C21	DUAL
1	IO_L44P_1/A20	C22	DUAL
1	IO_L45N_1/A23	B21	DUAL
1	IO_L45P_1/A22	B22	DUAL
1	IO_L46N_1/A25	G17	DUAL
1	IO_L46P_1/A24	G18	DUAL
1	IP_L04N_1/VREF_1	R16	VREF
1	IP_L04P_1	R15	INPUT
1	IP_L08N_1	P16	INPUT
1	IP_L08P_1	P15	INPUT
1	IP_L12N_1/VREF_1	R18	VREF
1	IP_L12P_1	R17	INPUT

Table 78: Spartan-3AN FGG484 Pinout (Cont'd)

Bank	Pin Name	FGG484 Ball	Type
1	IP_L16N_1/VREF_1	N16	VREF
1	IP_L16P_1	N15	INPUT
1	IP_L23N_1	M16	INPUT
1	IP_L23P_1	M17	INPUT
1	IP_L27N_1	L16	INPUT
1	IP_L27P_1/VREF_1	M15	VREF
1	IP_L31N_1	K16	INPUT
1	IP_L31P_1	L15	INPUT
1	IP_L35N_1	K15	INPUT
1	IP_L35P_1/VREF_1	K14	VREF
1	IP_L39N_1	H18	INPUT
1	IP_L39P_1	H17	INPUT
1	IP_L43N_1/VREF_1	J15	VREF
1	IP_L43P_1	J16	INPUT
1	IP_L47N_1	H15	INPUT
1	IP_L47P_1/VREF_1	H16	VREF
1	VCCO_1	E21	VCCO
1	VCCO_1	J17	VCCO
1	VCCO_1	K21	VCCO
1	VCCO_1	P17	VCCO
1	VCCO_1	P21	VCCO
1	VCCO_1	V21	VCCO
2	IO_L01N_2/M0	W5	DUAL
2	IO_L01P_2/M1	V6	DUAL
2	IO_L02N_2/CSO_B	Y4	DUAL
2	IO_L02P_2/M2	W4	DUAL
2	IO_L03N_2	AA3	I/O
2	IO_L03P_2	AB2	I/O
2	IO_L04N_2	AA4	I/O
2	IO_L04P_2	AB3	I/O
2	IO_L05N_2	Y5	I/O
2	IO_L05P_2	W6	I/O
2	IO_L06N_2	AB5	I/O
2	IO_L06P_2	AB4	I/O
2	IO_L07N_2	Y6	I/O
2	IO_L07P_2	W7	I/O
2	IO_L08N_2	AB6	I/O
2	IO_L08P_2	AA6	I/O
2	IO_L09N_2/VS2	W9	DUAL
2	IO_L09P_2/RDWR_B	V9	DUAL

User I/Os by Bank

Table 79 and Table 80 indicate how the user-I/O pins are distributed between the four I/O banks on the FGG484 package. The AWAKE pin is counted as a dual-purpose I/O.

Table 79: User I/Os Per Bank for the XC3S700AN in the FGG484 Package

Package Edge	I/O Bank	Maximum I/Os	All Possible I/O Pins by Type				
			I/O	INPUT	DUAL	VREF	CLK
Top	0	92	58	17	1	8	8
Right	1	94	33	15	30	8	8
Bottom	2	92	43	11	21	9	8
Left	3	94	61	17	0	8	8
Total		372	195	60	52	33	32

Table 80: User I/Os Per Bank for the XC3S1400AN in the FGG484 Package

Package Edge	I/O Bank	Maximum I/Os	All Possible I/O Pins by Type				
			I/O	INPUT	DUAL	VREF	CLK
Top	0	92	58	17	1	8	8
Right	1	94	33	15	30	8	8
Bottom	2	95	43	13	21	10	8
Left	3	94	61	17	0	8	8
Total		375	195	62	52	34	32

Footprint Migration Differences

Table 81 summarizes the three footprint and functionality differences between the XC3S700AN and the XC3S1400AN FPGAs that can affect migration between devices available in the FGG484 package. All other pins unconditionally migrate between the Spartan-3AN devices available in the FGG484 package.

Spartan-3AN FPGAs are pin compatible with the same density Spartan-3A FPGAs in the FG(G)484 package, although the Spartan-3A FPGAs require an external configuration source.

In Table 81, the arrow (→) indicates that this pin can unconditionally migrate from the device on the left to the device on the right. Migration in the other direction is possible depending on how the pin is configured for the device on the right.

Table 81: FGG484 XC3S700AN to XC3S1400AN Footprint Migration/Differences

FGG484 Ball	Bank	XC3S700AN	Migration	XC3S1400AN
T8	2	N.C.	→	INPUT/VREF
U7	2	N.C.	→	INPUT
U16	2	N.C.	→	INPUT
Number of Differences:			3	

Table 82: Spartan-3AN FGG676 Pinout (Cont'd)

Bank	Pin Name	FGG676 Ball	Type
2	IO_L15N_2	AC9	I/O
2	IO_L15P_2	AB9	I/O
2	IO_L16N_2	W12	I/O
2	IO_L16P_2	V12	I/O
2	IO_L17N_2/VS2	AA12	DUAL
2	IO_L17P_2/RDWR_B	Y12	DUAL
2	IO_L18N_2	AF8	I/O
2	IO_L18P_2	AE8	I/O
2	IO_L19N_2/VS0	AF9	DUAL
2	IO_L19P_2/VS1	AE9	DUAL
2	IO_L20N_2	W13	I/O
2	IO_L20P_2	V13	I/O
2	IO_L21N_2	AC12	I/O
2	IO_L21P_2	AB12	I/O
2	IO_L22N_2/D6	AF10	DUAL
2	IO_L22P_2/D7	AE10	DUAL
2	IO_L23N_2	AC11	I/O
2	IO_L23P_2	AD11	I/O
2	IO_L24N_2/D4	AE12	DUAL
2	IO_L24P_2/D5	AF12	DUAL
2	IO_L25N_2/GCLK13	Y13	GCLK
2	IO_L25P_2/GCLK12	AA13	GCLK
2	IO_L26N_2/GCLK15	AE13	GCLK
2	IO_L26P_2/GCLK14	AF13	GCLK
2	IO_L27N_2/GCLK1	AA14	GCLK
2	IO_L27P_2/GCLK0	Y14	GCLK
2	IO_L28N_2/GCLK3	AE14	GCLK
2	IO_L28P_2/GCLK2	AF14	GCLK
2	IO_L29N_2	AC14	I/O
2	IO_L29P_2	AD14	I/O
2	IO_L30N_2/MOSI/CSI_B	AB15	DUAL
2	IO_L30P_2	AC15	I/O
2	IO_L31N_2	W15	I/O
2	IO_L31P_2	V14	I/O
2	IO_L32N_2/DOOUT	AE15	DUAL
2	IO_L32P_2/AWAKE	AD15	PWR MGMT
2	IO_L33N_2	AD17	I/O
2	IO_L33P_2	AE17	I/O
2	IO_L34N_2/D3	Y15	DUAL
2	IO_L34P_2/INIT_B	AA15	DUAL

Table 82: Spartan-3AN FGG676 Pinout (Cont'd)

Bank	Pin Name	FGG676 Ball	Type
2	IO_L35N_2	U15	I/O
2	IO_L35P_2	V15	I/O
2	IO_L36N_2/D1	AE18	DUAL
2	IO_L36P_2/D2	AF18	DUAL
2	IO_L37N_2	AE19	I/O
2	IO_L37P_2	AF19	I/O
2	IO_L38N_2	AB16	I/O
2	IO_L38P_2	AC16	I/O
2	IO_L39N_2	AE20	I/O
2	IO_L39P_2	AF20	I/O
2	IO_L40N_2	AC19	I/O
2	IO_L40P_2	AD19	I/O
2	IO_L41N_2	AC20	I/O
2	IO_L41P_2	AD20	I/O
2	IO_L42N_2	U16	I/O
2	IO_L42P_2	V16	I/O
2	IO_L43N_2	Y17	I/O
2	IO_L43P_2	AA17	I/O
2	IO_L44N_2	AD21	I/O
2	IO_L44P_2	AE21	I/O
2	IO_L45N_2	AC21	I/O
2	IO_L45P_2	AD22	I/O
2	IO_L46N_2	V17	I/O
2	IO_L46P_2	W17	I/O
2	IO_L47N_2	AA18	I/O
2	IO_L47P_2	AB18	I/O
2	IO_L48N_2	AE23	I/O
2	IO_L48P_2	AF23	I/O
2	IO_L51N_2	AE25	I/O
2	IO_L51P_2	AF25	I/O
2	IO_L52N_2/CCLK	AE24	DUAL
2	IO_L52P_2/D0/DIN/MISO	AF24	DUAL
2	IP_2	AA19	INPUT
2	IP_2	AB13	INPUT
2	IP_2	AB17	INPUT
2	IP_2	AB20	INPUT
2	IP_2	AC7	INPUT
2	IP_2	AC13	INPUT
2	IP_2	AC17	INPUT
2	IP_2	AC18	INPUT